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Home > Support > Design Support > Design Resources & Documents > Evaluation/Development Tools

NCP1607B00STGEVB: 100 W Boost Evaluation Board

The NCP1607 is a voltage mode power factor correction controller designed to drive cost-effective converters to meet input line harmonic regulations. The device operates in Critical Conduction Mode (CRM) for optimal performance in applications up to about 300 W. Its voltage mode scheme enables it to obtain unity power factor without the need for a line sensing network. The output voltage is accurately controlled with a built in high precision error amplifier. The controller also implements a comprehensive array of safety features for robust designs.



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Features and Applications

Features

- High power factor
- Low standby power dissipation
- High active mode efficiency
- Open feedback loop protection

Evaluation/Development Tool Information						
Product	Status	Compliance	Short Description	Parts Used	Action	
NCP1607BOOSTGEVB		Pb-free	100 W Boost Evaluation Board	NCP1607BDR2G	 Contact Local Sales Office Inventory 	

Technical Documents						
Туре	Document Title	Document ID/Size	Rev			
Eval Board: BOM	NCP1607BOOSTGEVB Bill of Materials ROHS Compliant	NCP1607BOOSTEVB_BOM_ROHS.PDF - 139.0 KB	0			
Eval Board: Gerber	NCP1607BOOSTEVB Gerber Layout Files (Zip Format)	NCP1607BOOSTEVB_GERBER.ZIP - 49.0 KB	0			
Eval Board: Schematic	NCP1607BOOSTEVB Schematic	NCP1607BOOSTEVB_SCHEMATIC.PDF - 126.0 KB	0			
Eval Board: Test Procedure	NCP1607BOOSTEVB Test Procedure	NCP1607BOOSTEV_TEST_PROCEDURE.PDF - 232.0 KB	0			

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